

N-channel 650 V, 0.054 Ω, 50 A MDmesh™ II Power MOSFET  
TO-247

## Features

| Type       | V <sub>DSS</sub><br>(@T <sub>jmax</sub> ) | R <sub>DS(on)</sub><br>max | I <sub>D</sub> |
|------------|-------------------------------------------|----------------------------|----------------|
| STW54NM65N | 710 V                                     | < 0.065 Ω                  | 50 A           |

- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

## Application

- Switching applications

## Description

This series of devices is designed using the second generation of MDmesh™ technology. This revolutionary Power MOSFET associates a new vertical structure to the STMicroelectronics' strip layout to yield one of the world's lowest on-resistance and gate charge. It is therefore suitable for the most demanding high efficiency converters.

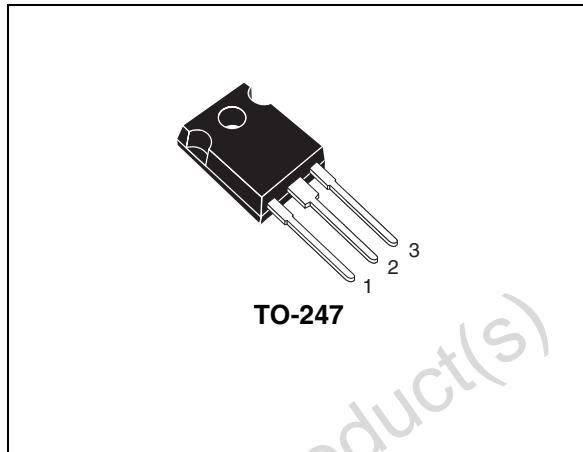


Figure 1. Internal schematic diagram

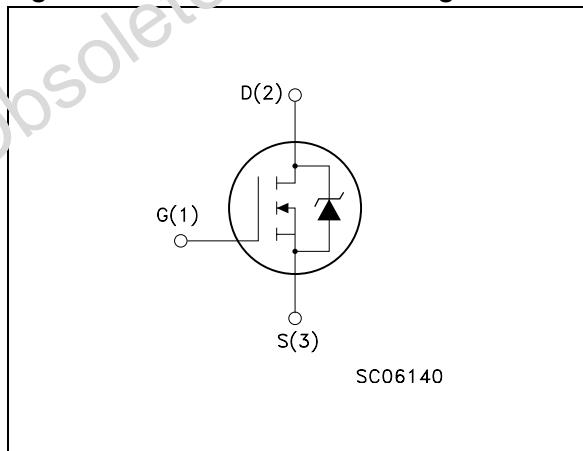


Table 1 Device summary

| Order code | Marking | Package | Packaging |
|------------|---------|---------|-----------|
| STW54NM65N | 54NM65N | TO-247  | Tube      |

## Contents

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# 1 Electrical ratings

**Table 2. Absolute maximum ratings**

| Symbol         | Parameter                                               | Value      | Unit             |
|----------------|---------------------------------------------------------|------------|------------------|
| $V_{DS}$       | Drain-source voltage ( $V_{GS} = 0$ )                   | 650        | V                |
| $V_{GS}$       | Gate- source voltage                                    | $\pm 25$   | V                |
| $I_D$          | Drain current (continuous) at $T_C = 25^\circ\text{C}$  | 50         | A                |
| $I_D$          | Drain current (continuous) at $T_C = 100^\circ\text{C}$ | 31.5       | A                |
| $I_{DM}^{(1)}$ | Drain current (pulsed)                                  | 200        | A                |
| $P_{TOT}$      | Total dissipation at $T_C = 25^\circ\text{C}$           | 350        | W                |
| $dv/dt^{(2)}$  | Peak diode recovery voltage slope                       | 15         | V/ns             |
| $T_{stg}$      | Storage temperature                                     | -55 to 150 | $^\circ\text{C}$ |
| $T_j$          | Max. operating junction temperature                     | 150        | $^\circ\text{C}$ |

1. Pulse width limited by safe operating area  
 2.  $I_{SD} \leq 50$  A,  $di/dt \leq 400$  A/ $\mu\text{s}$ ,  $V_{DD} = 80\%$   $V_{(BR)DSS}$

**Table 3. Thermal data**

| Symbol         | Parameter                                      | Value | Unit               |
|----------------|------------------------------------------------|-------|--------------------|
| $R_{thj-case}$ | Thermal resistance junction-case max           | 0.36  | $^\circ\text{C/W}$ |
| $R_{thj-amb}$  | Thermal resistance junction-ambient max        | 50    | $^\circ\text{C/W}$ |
| $T_I$          | Maximum lead temperature for soldering purpose | 300   | $^\circ\text{C}$   |

**Table 4. Avalanche characteristics**

| Symbol   | Parameter                                                                                            | Value | Unit |
|----------|------------------------------------------------------------------------------------------------------|-------|------|
| $I_{AS}$ | Avalanche current, repetitive or not-repetitive (pulse width limited by $T_j$ max)                   | 14    | A    |
| $E_{AS}$ | Single pulse avalanche energy (starting $T_j = 25^\circ\text{C}$ , $I_D = I_{AS}$ , $V_{DD} = 50$ V) | 1600  | mJ   |

## 2 Electrical characteristics

( $T_{CASE} = 25^\circ\text{C}$  unless otherwise specified)

**Table 5. On/off states**

| Symbol              | Parameter                                        | Test conditions                                                                    | Min. | Typ.  | Max.     | Unit                           |
|---------------------|--------------------------------------------------|------------------------------------------------------------------------------------|------|-------|----------|--------------------------------|
| $V_{(BR)DSS}$       | Drain-source breakdown voltage                   | $I_D = 1\text{mA}$ , $V_{GS} = 0$                                                  | 650  |       |          | V                              |
| $dv/dt^{(1)}$       | Drain source voltage slope                       | $V_{DD} = 520\text{ V}$ , $I_D = 50\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$          |      | 35    |          | V/ns                           |
| $I_{DSS}$           | Zero gate voltage drain current ( $V_{GS} = 0$ ) | $V_{DS} = \text{Max rating}$<br>$V_{DS} = \text{Max rating, @ } 125^\circ\text{C}$ |      |       | 1<br>100 | $\mu\text{A}$<br>$\mu\text{A}$ |
| $I_{GSS}$           | Gate-body leakage current ( $V_{DS} = 0$ )       | $V_{GS} = \pm 20\text{ V}$                                                         |      |       | 100      | nA                             |
| $V_{GS(\text{th})}$ | Gate threshold voltage                           | $V_{DS} = V_{GS}$ , $I_D = 250\text{ }\mu\text{A}$                                 | 2    | 3     | 4        | V                              |
| $R_{DS(\text{on})}$ | Static drain-source on resistance                | $V_{GS} = 10\text{ V}$ , $I_D = 25\text{ A}$                                       |      | 0.054 | 0.065    | $\Omega$                       |

1. Characteristic value at turn off on inductive load

**Table 6. Dynamic**

| Symbol                              | Parameter                                                               | Test conditions                                                                                | Min. | Typ.              | Max. | Unit           |
|-------------------------------------|-------------------------------------------------------------------------|------------------------------------------------------------------------------------------------|------|-------------------|------|----------------|
| $g_{fs}^{(1)}$                      | Forward transconductance                                                | $V_{DS}=15\text{ V}$ , $I_D = 25\text{ A}$                                                     |      | 45                |      | S              |
| $C_{iss}$<br>$C_{oss}$<br>$C_{rss}$ | Input capacitance<br>Output capacitance<br>Reverse transfer capacitance | $V_{DS} = 50\text{ V}$ , $f = 1\text{ MHz}$ ,<br>$V_{GS} = 0$                                  |      | 6000<br>320<br>35 |      | pF<br>pF<br>pF |
| $C_{oss\text{ eq.}}^{(2)}$          | Equivalent output capacitance                                           | $V_{GS} = 0$ , $V_{DS} = 0$ to $520\text{ V}$                                                  |      | 690               |      | pF             |
| $Q_g$<br>$Q_{gs}$<br>$Q_{gd}$       | Total gate charge<br>Gate-source charge<br>Gate-drain charge            | $V_{DD} = 520\text{ V}$ , $I_D = 50\text{ A}$ ,<br>$V_{GS} = 10\text{ V}$ ,<br>(see Figure 15) |      | 200<br>20<br>110  |      | nC<br>nC<br>nC |
| $R_g$                               | Gate input resistance                                                   | $f=1\text{ MHz}$ gate DC bias=0<br>Test signal level = $20\text{ mV}$<br>open drain            |      | 1.9               |      | $\Omega$       |

1. Pulsed: Pulse duration =  $300\text{ }\mu\text{s}$ , duty cycle 1.5%

2.  $C_{oss\text{ eq.}}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DS}$

**Table 7. Switching times**

| Symbol       | Parameter           | Test conditions                                                                                                  | Min. | Typ. | Max. | Unit |
|--------------|---------------------|------------------------------------------------------------------------------------------------------------------|------|------|------|------|
| $t_{d(on)}$  | Turn-on delay time  |                                                                                                                  |      | 30   |      | ns   |
| $t_r$        | Rise time           |                                                                                                                  |      | 50   |      | ns   |
| $t_{d(off)}$ | Turn-off delay time | $V_{DD} = 325 \text{ V}$ , $I_D = 25 \text{ A}$<br>$R_G = 4.7 \Omega$ $V_{GS} = 10 \text{ V}$<br>(see Figure 14) |      | 240  |      | ns   |
| $t_f$        | Fall time           |                                                                                                                  |      | 100  |      | ns   |

**Table 8. Source drain diode**

| Symbol          | Parameter                     | Test conditions                                               | Min | Typ. | Max | Unit          |
|-----------------|-------------------------------|---------------------------------------------------------------|-----|------|-----|---------------|
| $I_{SD}$        | Source-drain current          |                                                               |     |      | 50  | A             |
| $I_{SDM}^{(1)}$ | Source-drain current (pulsed) |                                                               |     |      | 200 | A             |
| $V_{SD}^{(2)}$  | Forward on voltage            | $I_{SD} = 50 \text{ A}$ , $V_{GS} = 0$                        |     |      | 1.3 | V             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 50 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ |     | 630  |     | ns            |
| $Q_{rr}$        | Reverse recovery charge       | $V_{DD} = 100 \text{ V}$                                      |     | 18   |     | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      | (see Figure 16)                                               |     | 55   |     | A             |
| $t_{rr}$        | Reverse recovery time         | $I_{SD} = 50 \text{ A}$ , $dI/dt = 100 \text{ A}/\mu\text{s}$ |     | 750  |     | ns            |
| $Q_{rr}$        | Reverse recovery charge       | $V_{DD} = 100 \text{ V}$ , $T_j = 150^\circ\text{C}$          |     | 22   |     | $\mu\text{C}$ |
| $I_{RRM}$       | Reverse recovery current      | (see Figure 16)                                               |     | 58   |     | A             |

1. Pulse width limited by safe operating area  
 2. Pulsed: Pulse duration = 300  $\mu\text{s}$ , duty cycle 1.5%

## 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

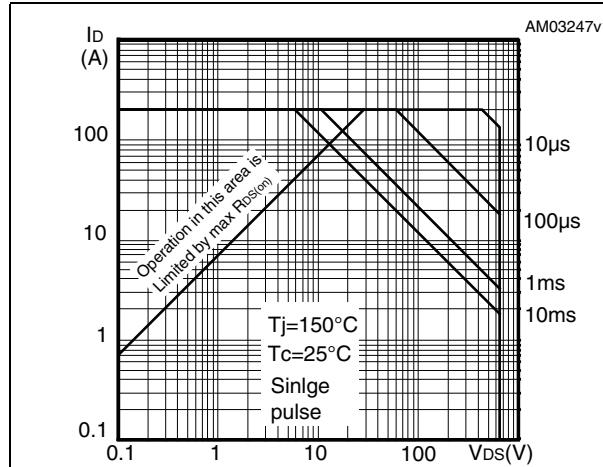


Figure 3. Thermal impedance

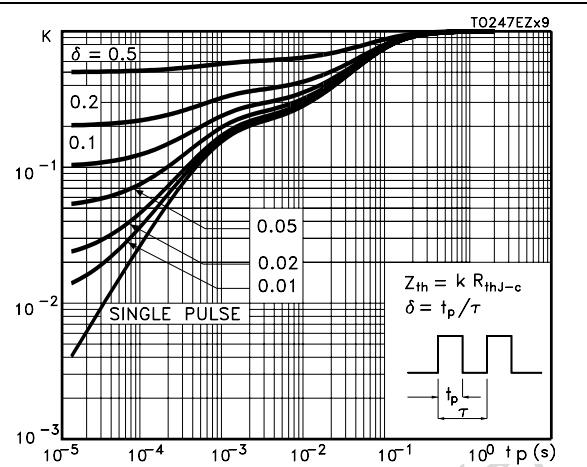


Figure 4. Output characteristics

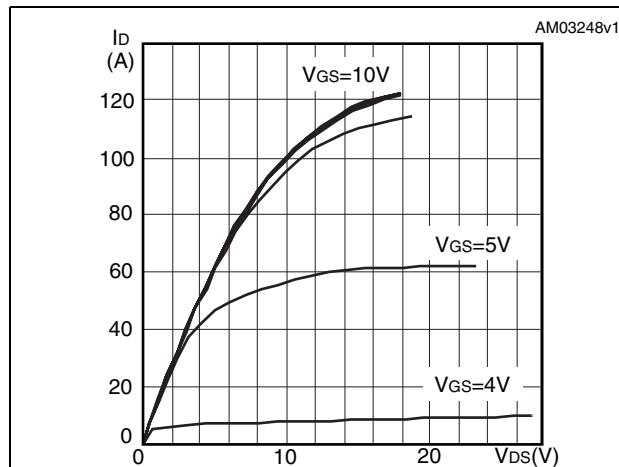


Figure 5. Transfer characteristics

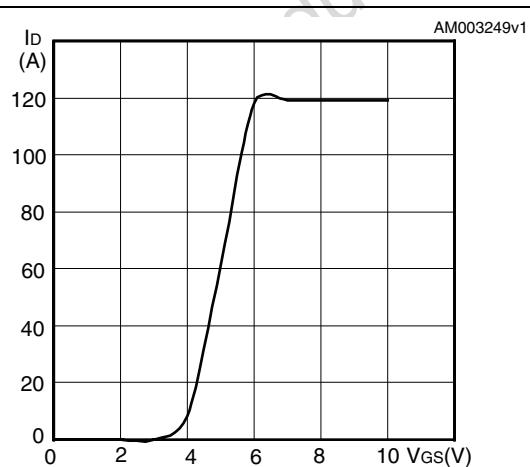


Figure 6. Transconductance

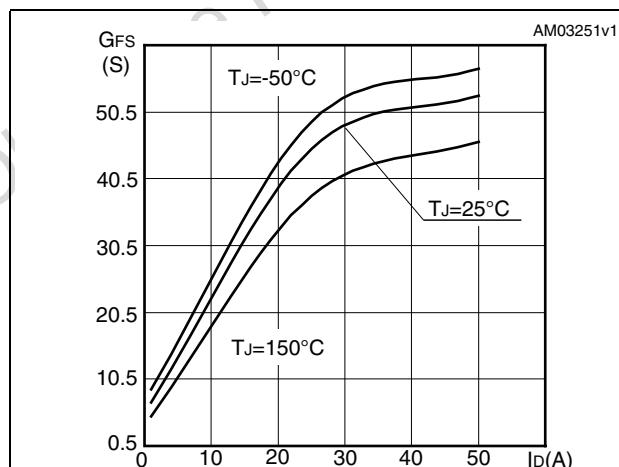
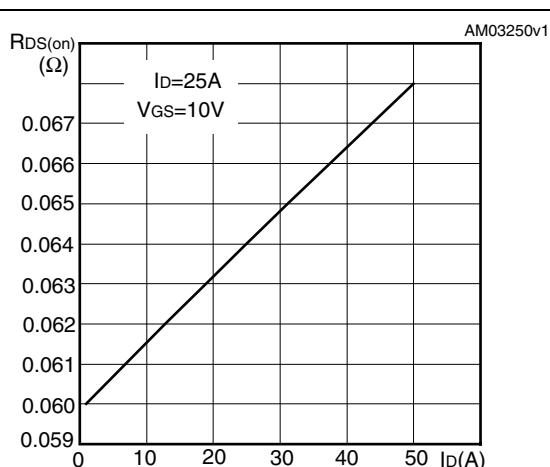
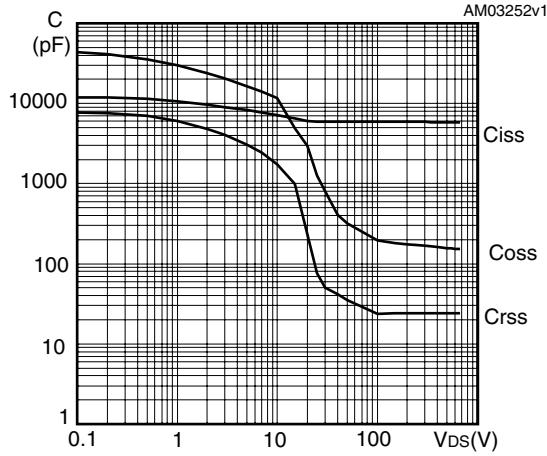
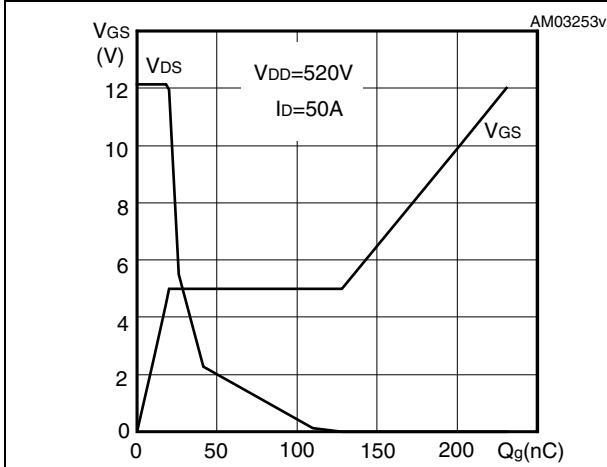
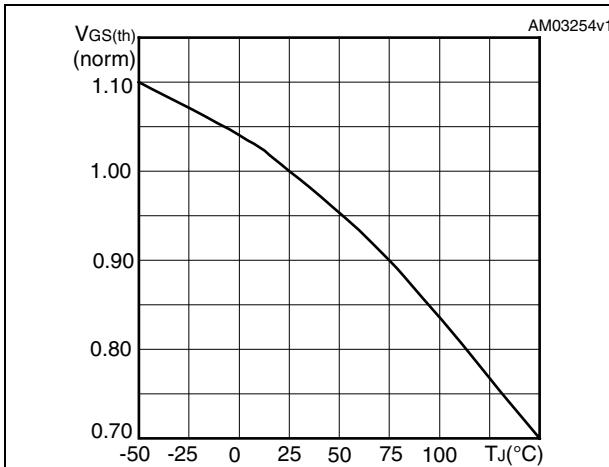
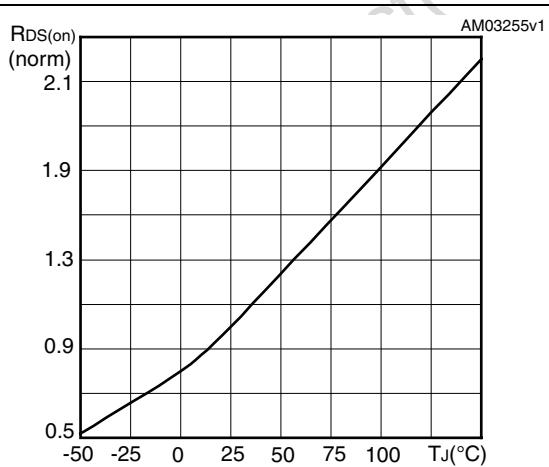
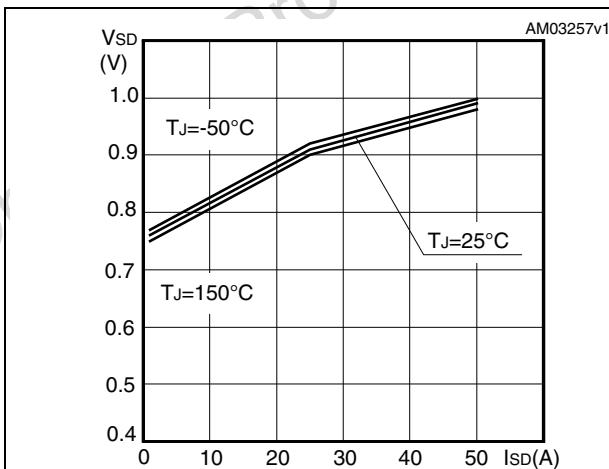
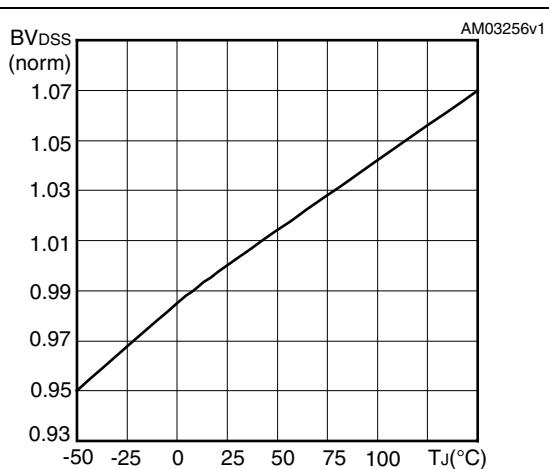


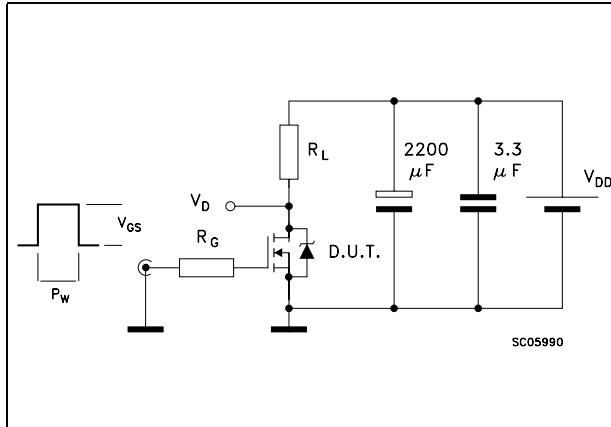
Figure 7. Static drain-source on resistance



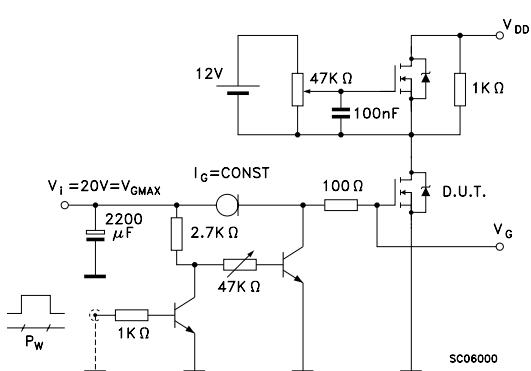
**Figure 8. Gate charge vs gate-source voltage****Figure 10. Normalized gate threshold voltage vs temperature****Figure 11. Normalized on resistance vs temperature****Figure 12. Source-drain diode forward characteristics****Figure 13. Normalized  $B_{VDSS}$  vs temperature**

### 3 Test circuit

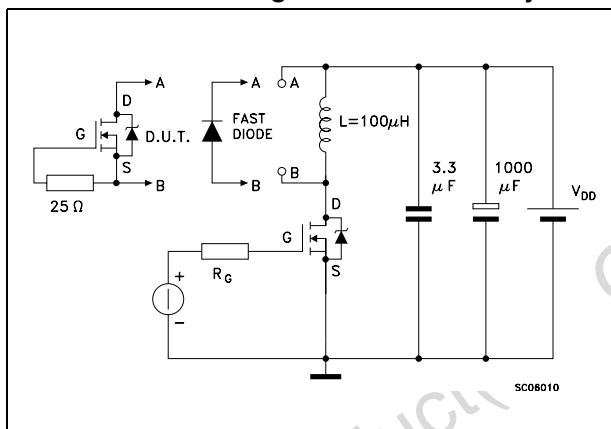
**Figure 14. Switching times test circuit for resistive load**



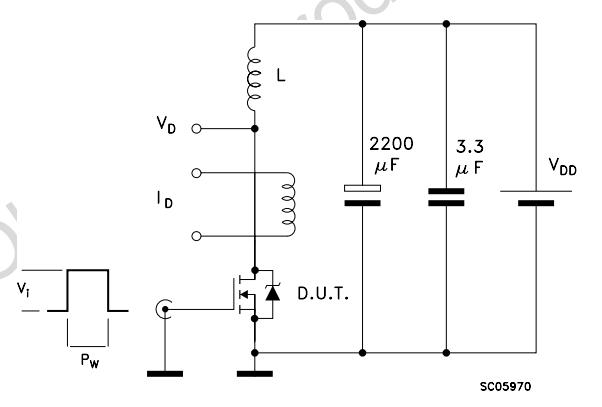
**Figure 15. Gate charge test circuit**



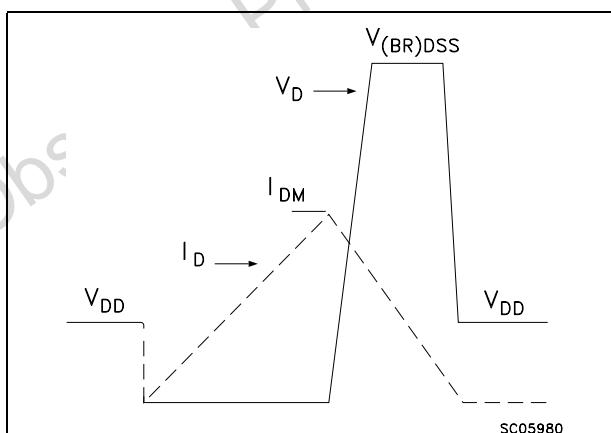
**Figure 16. Test circuit for inductive load switching and diode recovery times**



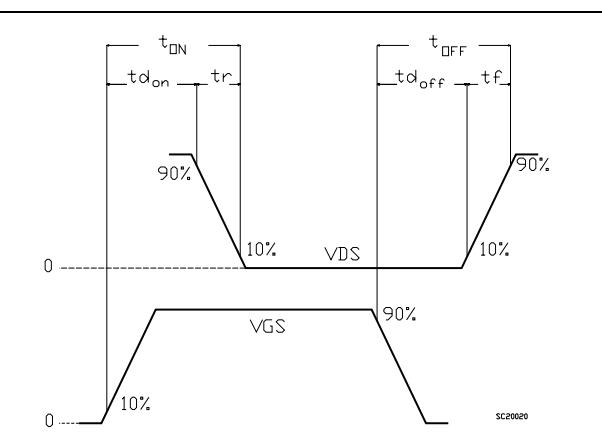
**Figure 17. Unclamped inductive load test circuit**



**Figure 18. Unclamped inductive waveform**



**Figure 19. Switching time waveform**



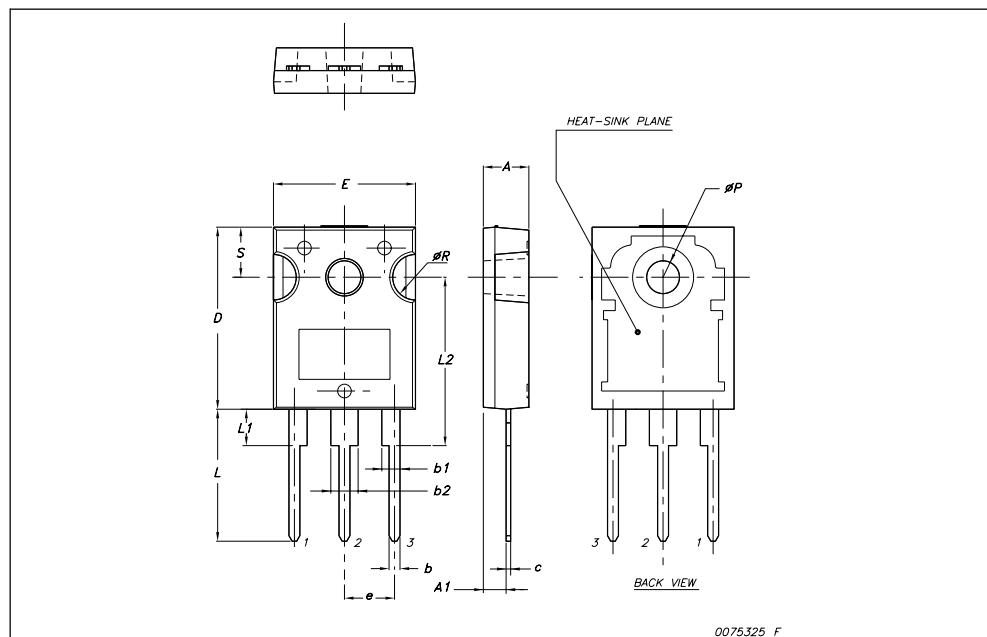
## 4 Package mechanical data

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## TO-247 Mechanical data

| Dim. | mm.   |       |       |
|------|-------|-------|-------|
|      | Min.  | Typ   | Max.  |
| A    | 4.85  |       | 5.15  |
| A1   | 2.20  |       | 2.60  |
| b    | 1.0   |       | 1.40  |
| b1   | 2.0   |       | 2.40  |
| b2   | 3.0   |       | 3.40  |
| c    | 0.40  |       | 0.80  |
| D    | 19.85 |       | 20.15 |
| E    | 15.45 |       | 15.75 |
| e    |       | 5.45  |       |
| L    | 14.20 |       | 14.80 |
| L1   | 3.70  |       | 4.30  |
| L2   |       | 18.50 |       |
| øP   | 3.55  |       | 3.65  |
| øR   | 4.50  |       | 5.50  |
| S    |       | 5.50  |       |



0075325 F

## 5 Revision history

**Table 9. Document revision history**

| Date        | Revision | Changes                                                      |
|-------------|----------|--------------------------------------------------------------|
| 24-Jul-2008 | 1        | Initial release                                              |
| 20-Jan-2009 | 2        | Document status promoted from preliminary data to datasheet. |

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